

## OptiMOS Power-Transistor

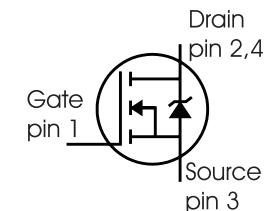
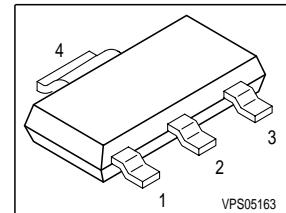
### Feature

- N-Channel
- Enhancement mode
- Logic Level

### Product Summary

|              |     |                  |
|--------------|-----|------------------|
| $V_{DS}$     | 55  | V                |
| $R_{DS(on)}$ | 33  | $\text{m}\Omega$ |
| $I_D$        | 5.2 | A                |

SOT-223



| Type      | Package | Ordering Code | Marking |
|-----------|---------|---------------|---------|
| BSP603S2L | SOT-223 | Q67060-S7213  | 2N603L  |

**Maximum Ratings**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter  | Symbol                | Value       | Unit             |
|--|-----------------------|-------------|------------------|
| Continuous drain current<br>$T_A=25^\circ\text{C}$ | $I_D$                 | 5.2         | A                |
| $T_A=70^\circ\text{C}$                             |                       | 4.1         |                  |
| Pulsed drain current<br>$T_A=25^\circ\text{C}$     | $I_{D \text{ puls}}$  | 21          |                  |
| Gate source voltage                                | $V_{GS}$              | $\pm 20$    | V                |
| Power dissipation<br>$T_A=25^\circ\text{C}$        | $P_{\text{tot}}$      | 1.8         | W                |
| Operating and storage temperature                  | $T_j, T_{\text{stg}}$ | -55... +150 | $^\circ\text{C}$ |
| IEC climatic category; DIN IEC 68-1                |                       | 55/150/00   |                  |

**Thermal Characteristics**

| Parameter  | Symbol     | Values |      |      | Unit |
|--|------------|--------|------|------|------|
|  |            | min.   | typ. | max. |      |
| <b>Characteristics</b>   |            |        |      |      |      |
| Thermal resistance, junction - soldering point<br>(Pin 4)  | $R_{thJS}$ | -      | -    | 20   | K/W  |
| Thermal resistance, chip to ambient air:<br>@ min. footprint<br>@ 6 cm <sup>2</sup> cooling area <sup>1)</sup> | $R_{thJA}$ | -      | -    | 120  |      |
|  |            | -      | -    | 70   |      |

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter  | Symbol              | Values |      |      | Unit             |
|--|---------------------|--------|------|------|------------------|
|  |                     | min.   | typ. | max. |                  |
| <b>Static Characteristics</b>  |                     |        |      |      |                  |
| Drain-source breakdown voltage<br>$V_{GS}=0\text{V}, I_D=1\text{mA}$   | $V_{(BR)DSS}$       | 55     | -    | -    | V                |
| Gate threshold voltage, $V_{GS} = V_{DS}$<br>$I_D=50\mu\text{A}$   | $V_{GS(\text{th})}$ | 1.2    | 1.6  | 2    |                  |
| Zero gate voltage drain current<br>$V_{DS}=55\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$<br>$V_{DS}=55\text{V}, V_{GS}=0\text{V}, T_j=150^\circ\text{C}$ | $I_{DSS}$           | -      | 0.1  | 1    | $\mu\text{A}$    |
| -  |                     | -      | 10   | 100  |                  |
| Gate-source leakage current<br>$V_{GS}=20\text{V}, V_{DS}=0\text{V}$   | $I_{GSS}$           | -      | 10   | 100  | nA               |
| Drain-source on-state resistance<br>$V_{GS}=4.5\text{V}, I_D=2.6\text{A}$  | $R_{DS(\text{on})}$ | -      | 25   | 40   | $\text{m}\Omega$ |
| Drain-source on-state resistance<br>$V_{GS}=10\text{V}, I_D=2.6\text{A}$   | $R_{DS(\text{on})}$ | -      | 21   | 33   |                  |

<sup>1)</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

#### Dynamic Characteristics

|                              |              |  |     |      |      |    |
|------------------------------|--------------|--|-----|------|------|----|
| Transconductance             | $g_{fs}$     | $V_{DS} \geq 2 * I_D * R_{DS(on)max}$ ,<br>$I_D = 5.2$                 | 8.9 | 17.8 | -    | S  |
| Input capacitance            | $C_{iss}$    | $V_{GS} = 0V$ , $V_{DS} = 25V$ ,<br>$f = 1\text{MHz}$                  | -   | 1034 | 1290 | pF |
| Output capacitance           | $C_{oss}$    |  | -   | 268  | 335  |    |
| Reverse transfer capacitance | $C_{rss}$    |  | -   | 83   | 125  |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD} = 30V$ , $V_{GS} = 4.5V$ ,<br>$I_D = 5.2A$ , $R_G = 5.6\Omega$ | -   | 10.8 | 16   | ns |
| Rise time                    | $t_r$        |  | -   | 16   | 24   |    |
| Turn-off delay time          | $t_{d(off)}$ |  | -   | 28   | 40   |    |
| Fall time                    | $t_f$        |  | -   | 15   | 23   |    |

#### Gate Charge Characteristics

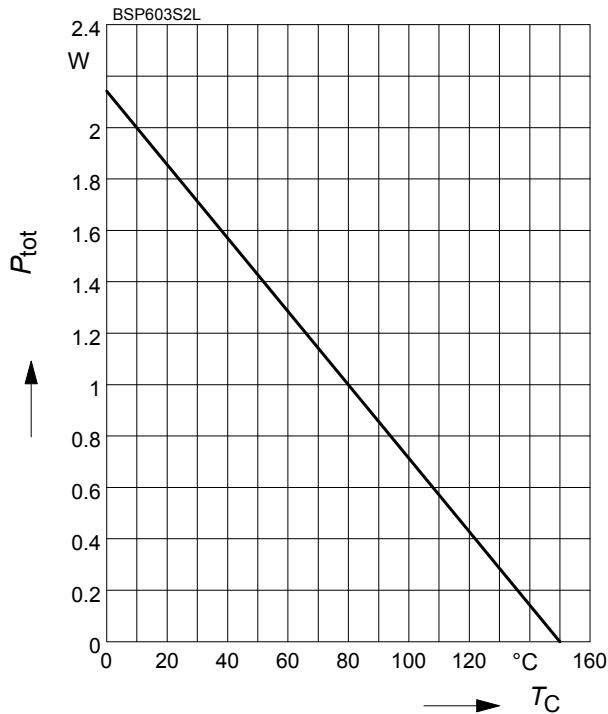
|                       |                 |  |   |      |     |    |
|-----------------------|-----------------|--|---|------|-----|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD} = 44V$ , $I_D = 5.2A$                            | - | 3.1  | 3.9 | nC |
| Gate to drain charge  | $Q_{gd}$        |  | - | 11.5 | 17  |    |
| Gate charge total     | $Q_g$           | $V_{DD} = 44V$ , $I_D = 5.2A$ ,<br>$V_{GS} = 0$ to $10V$ | - | 33   | 40  |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD} = 44V$ , $I_D = 5.2A$                            | - | 3    | -   | V  |

#### Reverse Diode

|  |          |   |   |     |     |    |
|--|----------|---|---|-----|-----|----|
| Inverse diode continuous forward current | $I_S$    | $T_A = 25^\circ\text{C}$                                    | - | -   | 5.2 | A  |
| Inverse diode direct current, pulsed     | $I_{SM}$ |   | - | -   | 21  |    |
| Inverse diode forward voltage            | $V_{SD}$ | $V_{GS} = 0V$ , $I_F = 5.2A$                                | - | 0.8 | 1.1 | V  |
| Reverse recovery time                    | $t_{rr}$ | $V_R = 30V$ , $I_F = I_S$ ,<br>$dI_F/dt = 100A/\mu\text{s}$ | - | 33  | 40  | ns |
| Reverse recovery charge                  | $Q_{rr}$ |   | - | 38  | 47  | nC |

### 1 Power dissipation

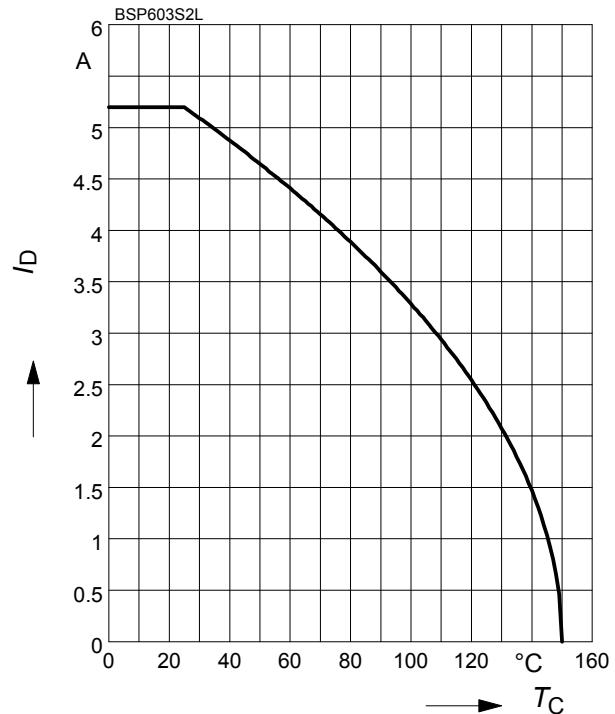
$$P_{\text{tot}} = f(T_C)$$



### 2 Drain current

$$I_D = f(T_C)$$

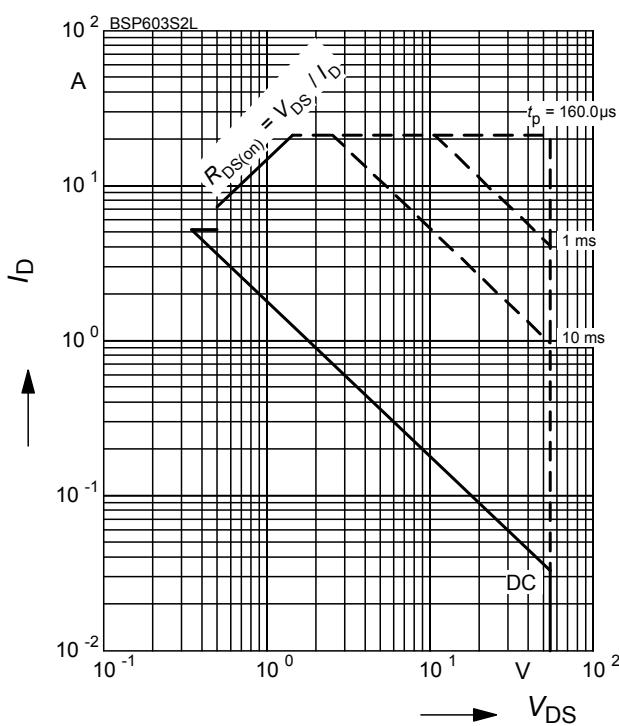
parameter:  $V_{GS} \geq 10$  V



### 3 Safe operating area

$$I_D = f(V_{DS})$$

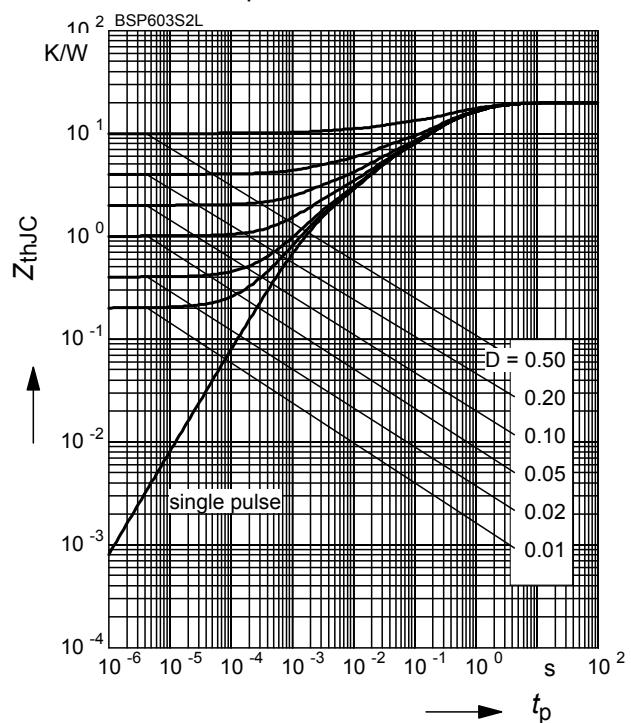
parameter :  $D = 0$  ,  $T_C = -$



### 4 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

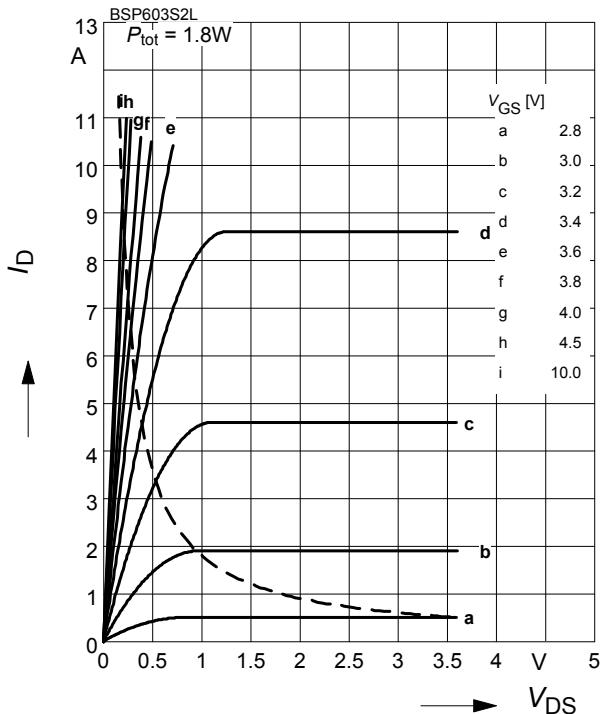
parameter :  $D = t_p/T$



### 5 Typ. output characteristic

$I_D = f(V_{DS})$ ;  $T_j=25^\circ\text{C}$

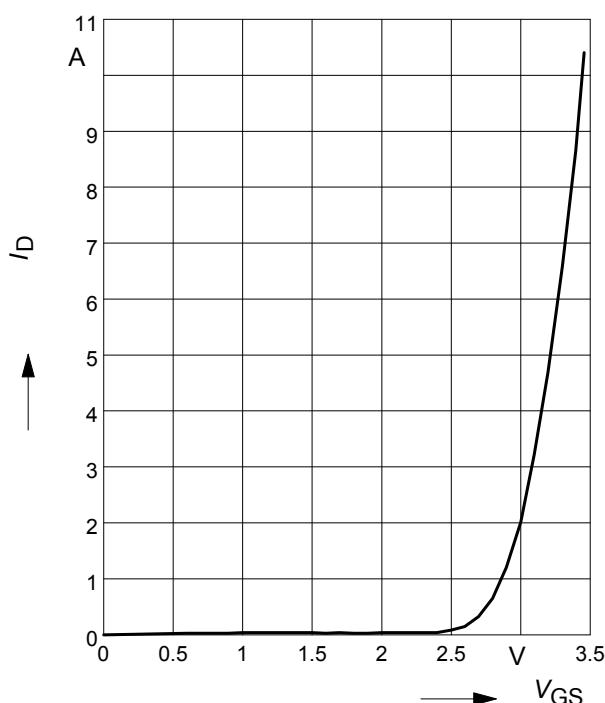
parameter:  $t_p = 80 \mu\text{s}$



### 7 Typ. transfer characteristics

$I_D = f(V_{GS})$ ;  $V_{DS} \geq 2 \times I_D \times R_{DS(on)}\max$

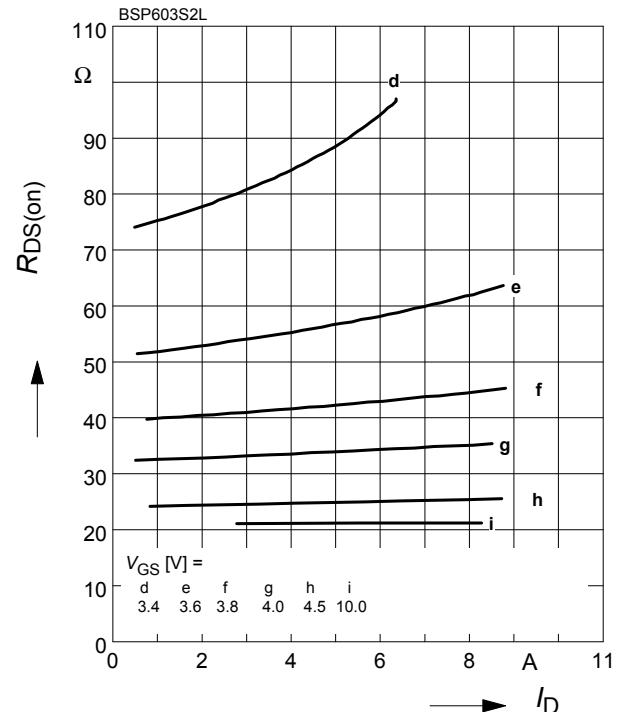
parameter:  $t_p = 80 \mu\text{s}$



### 6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

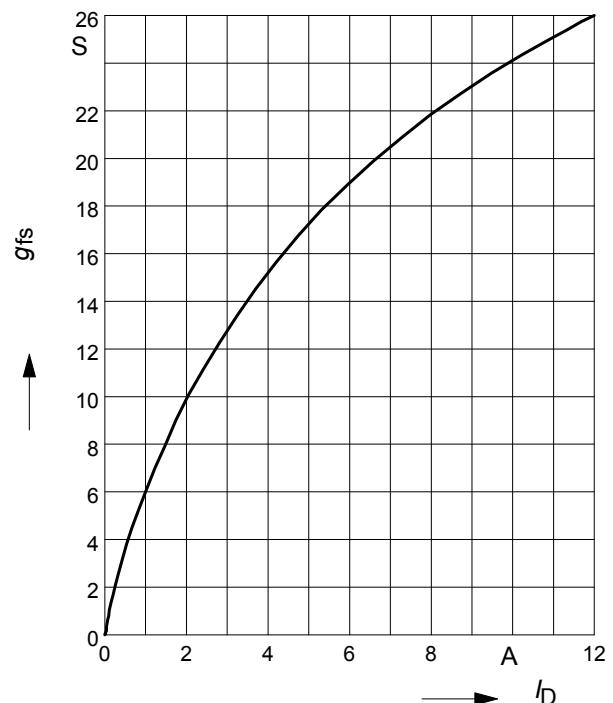
parameter:  $V_{GS}$



### 8 Typ. forward transconductance

$g_{fs} = f(I_D)$ ;  $T_j=25^\circ\text{C}$

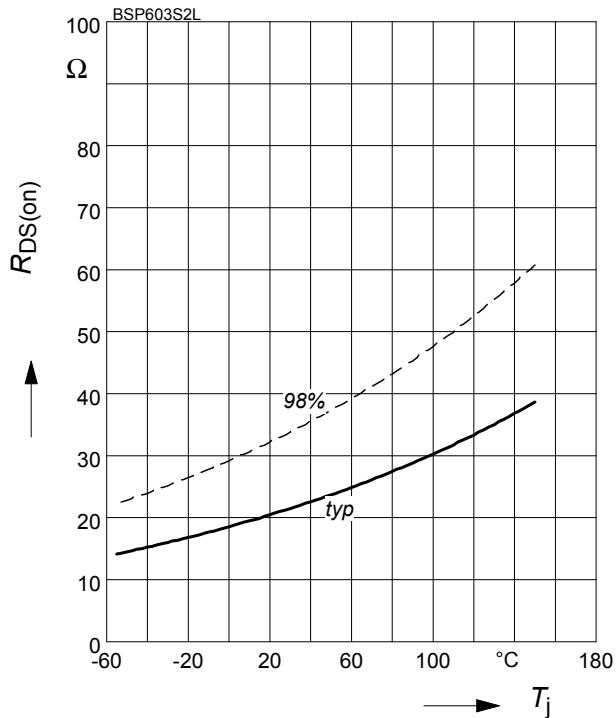
parameter:  $g_{fs}$



### 9 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

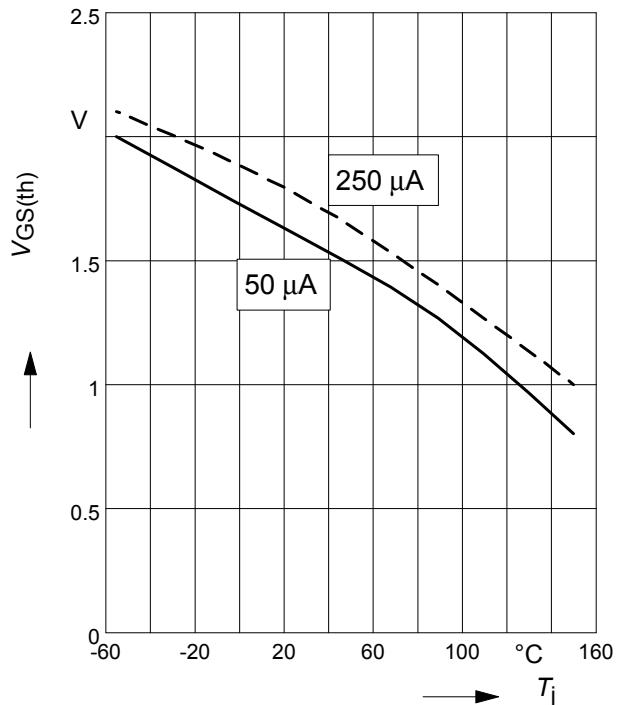
parameter :  $I_D = 2.6 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 10 Typ. gate threshold voltage

$$V_{GS(th)} = f(T_j)$$

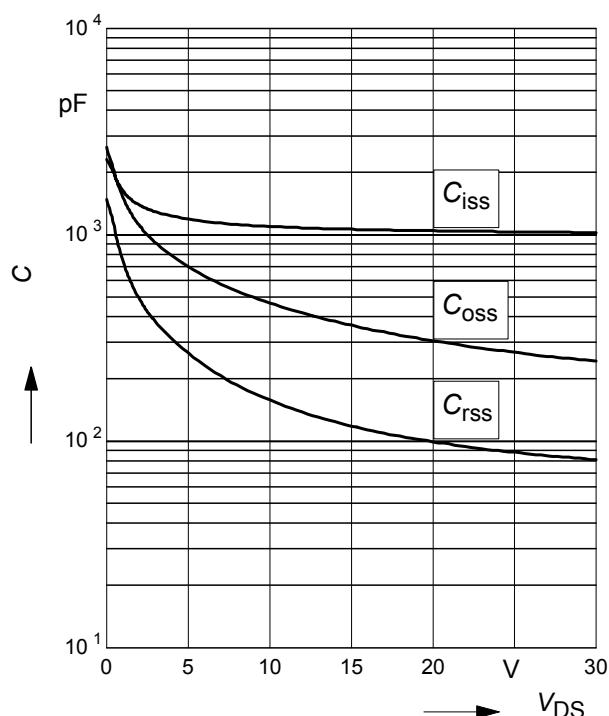
parameter:  $V_{GS} = V_{DS}$



### 11 Typ. capacitances

$$C = f(V_{DS})$$

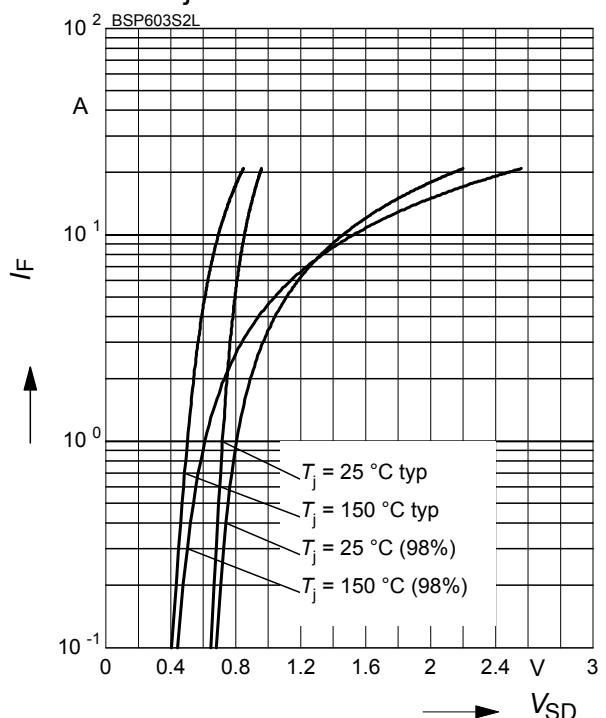
parameter:  $V_{GS}=0\text{V}$ ,  $f=1 \text{ MHz}$



### 12 Forward character. of reverse diode

$$I_F = f(V_{SD})$$

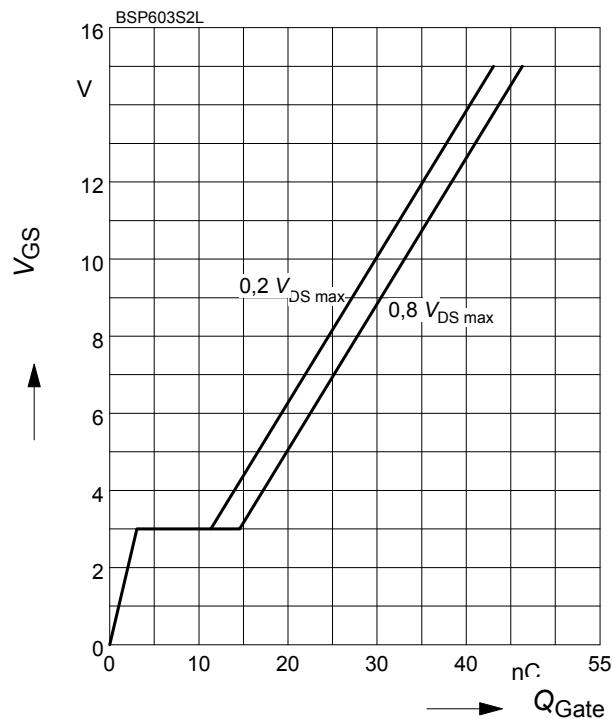
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



**13 Typ. gate charge**

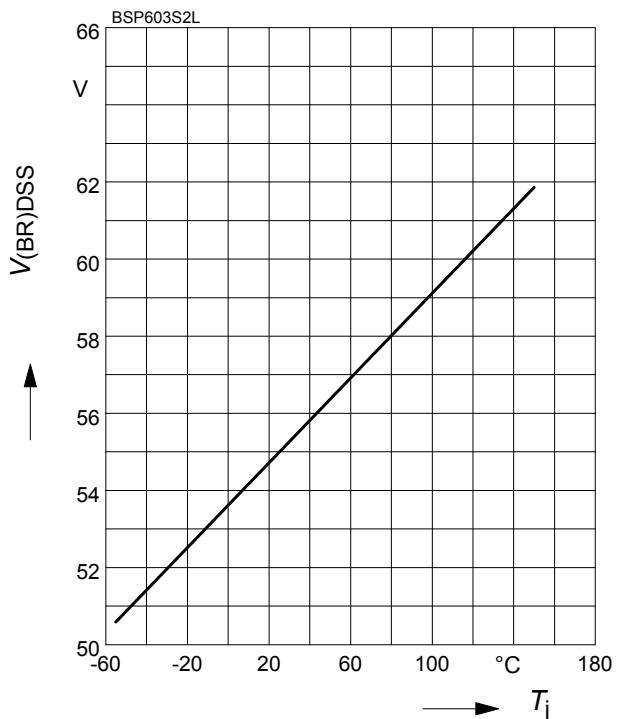
$$V_{GS} = f(Q_{Gate})$$

parameter:  $I_D = 5.2 \text{ A pulsed}$


**14 Drain-source breakdown voltage**

$$V_{(BR)DSS} = f(T_j)$$

parameter:  $I_D = 10 \text{ mA}$



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**Attention please!**

**Maximum soldering conditions: Maximum 3 times IR profile acc. to IPC 9501 (235°C +5/-0)**

**Jedec level 3**

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